

R5912 characterization

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Hamamatsu R5912 characterization

Six photomultiplier tubes were tested at FZU (Prague), current crosschecks in Brussels

Tests:

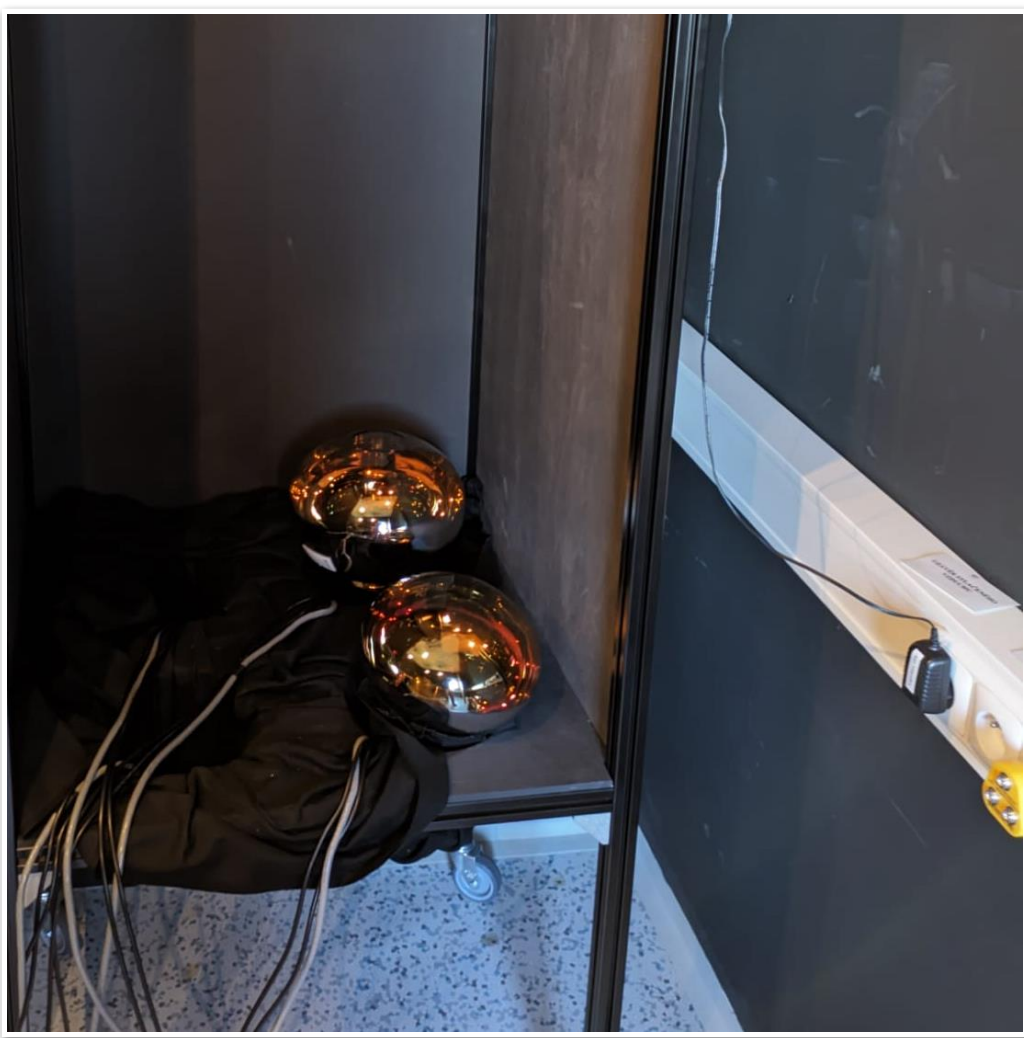
- Single Photo Electron spectrum
- Gain VS high voltage
- Non-linearity
- Afterpulse analysis
- Dark rate



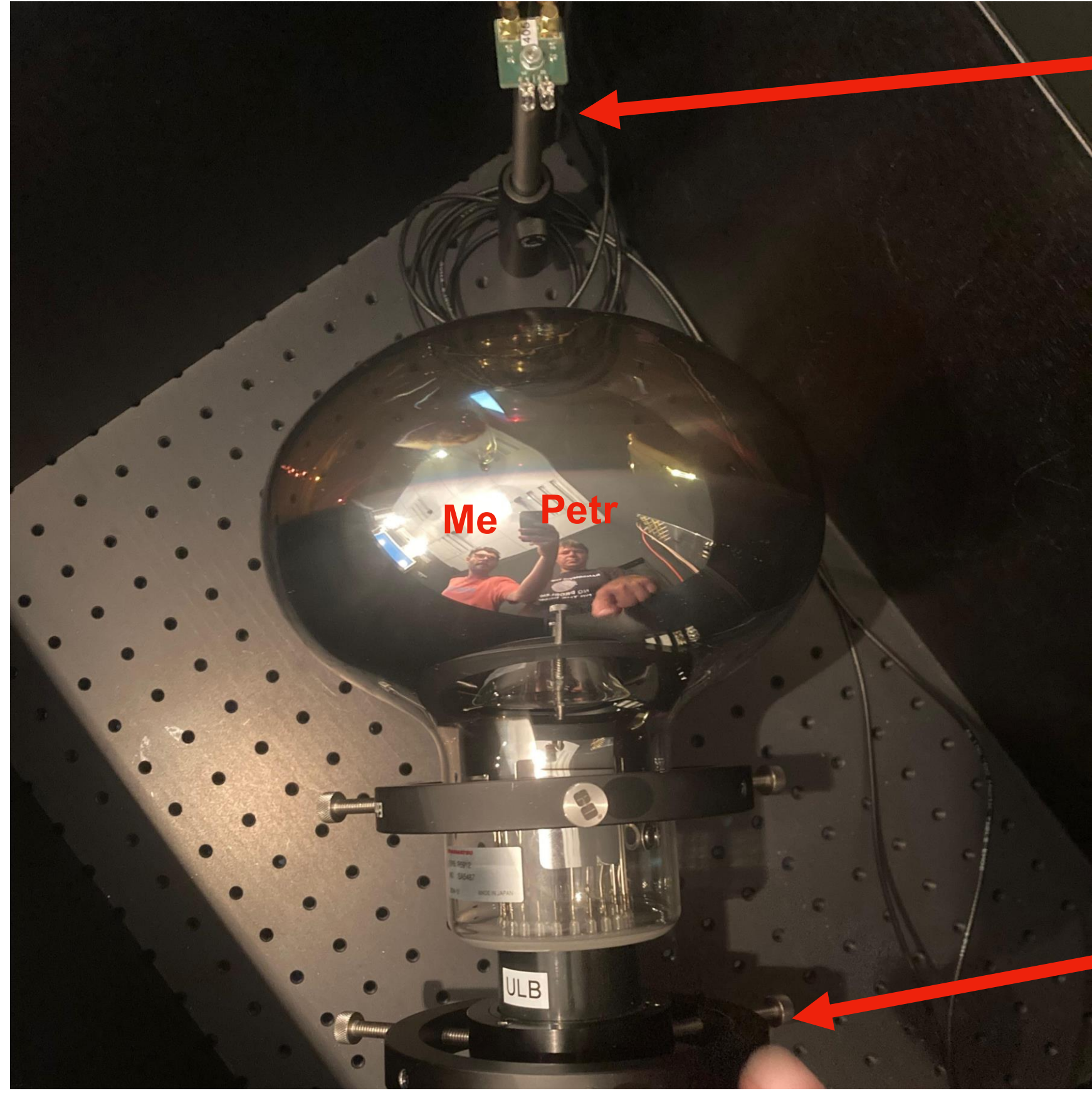
Experimental setup (@ FZU, Prague)



PMT placing inside the black box

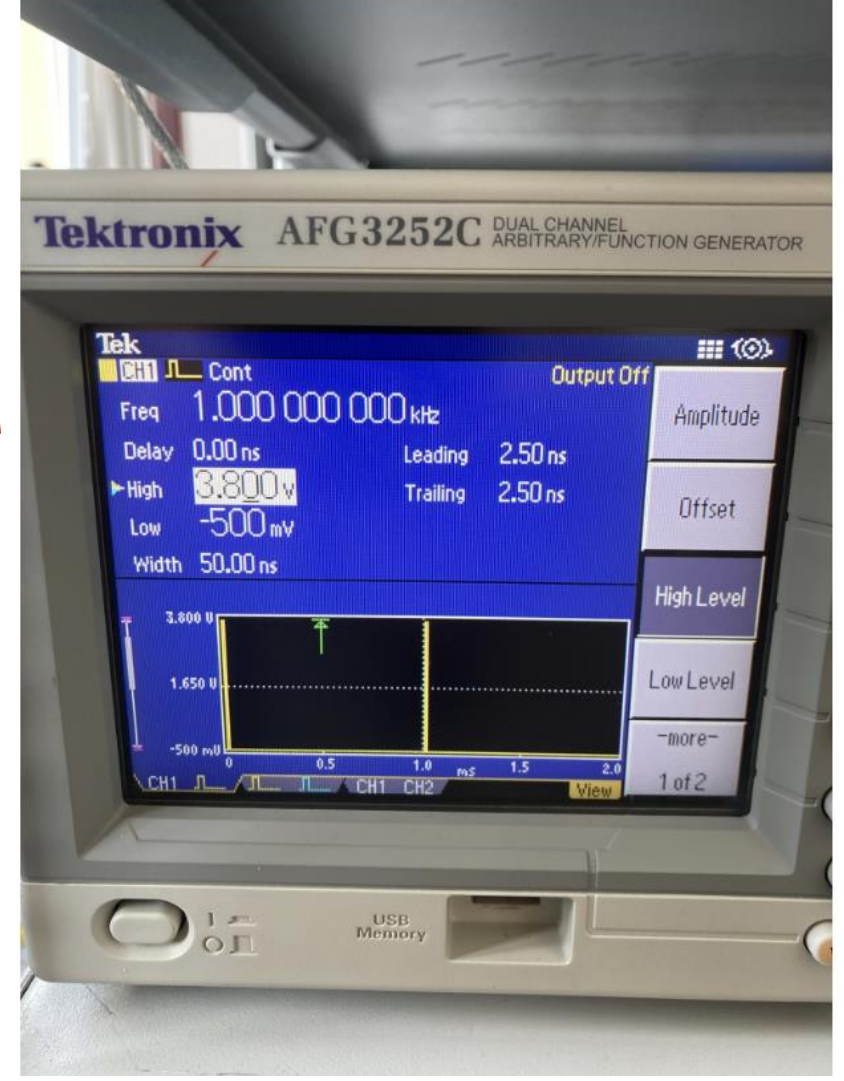


2 LED ($\lambda = 405 \text{ nm}$)

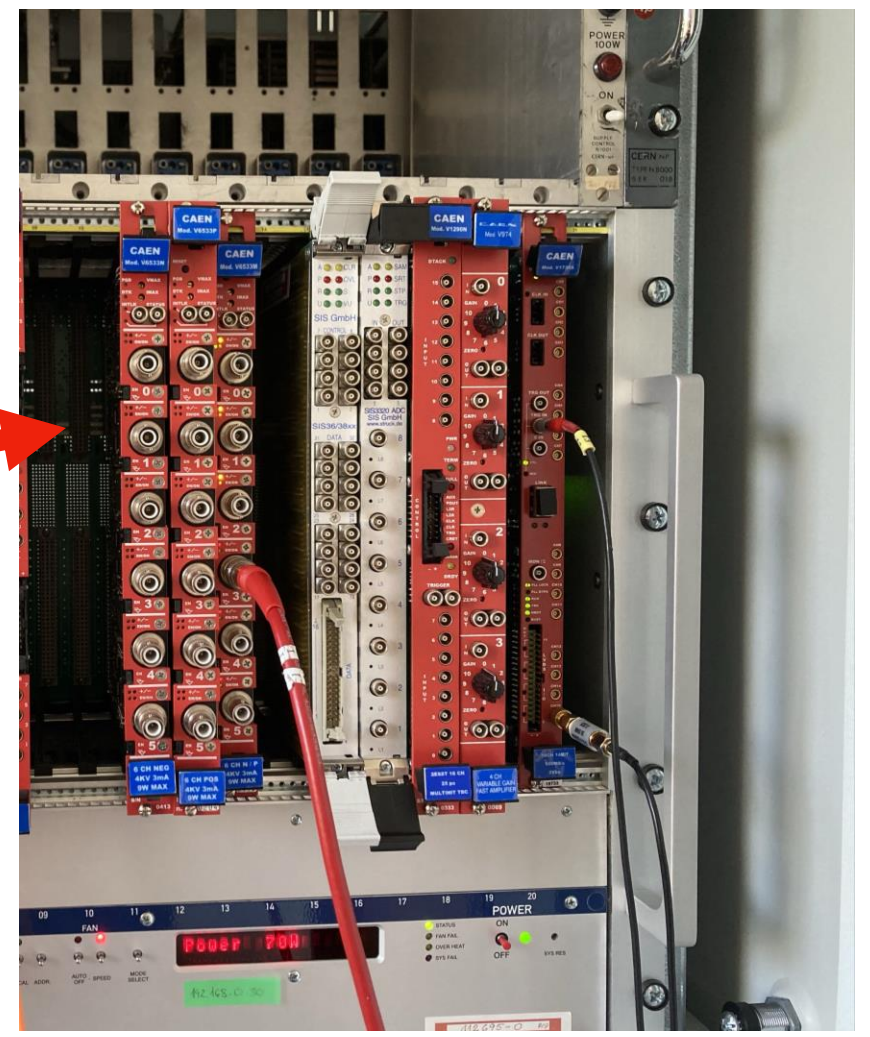


Hamamatsu base: HV input / signal readout

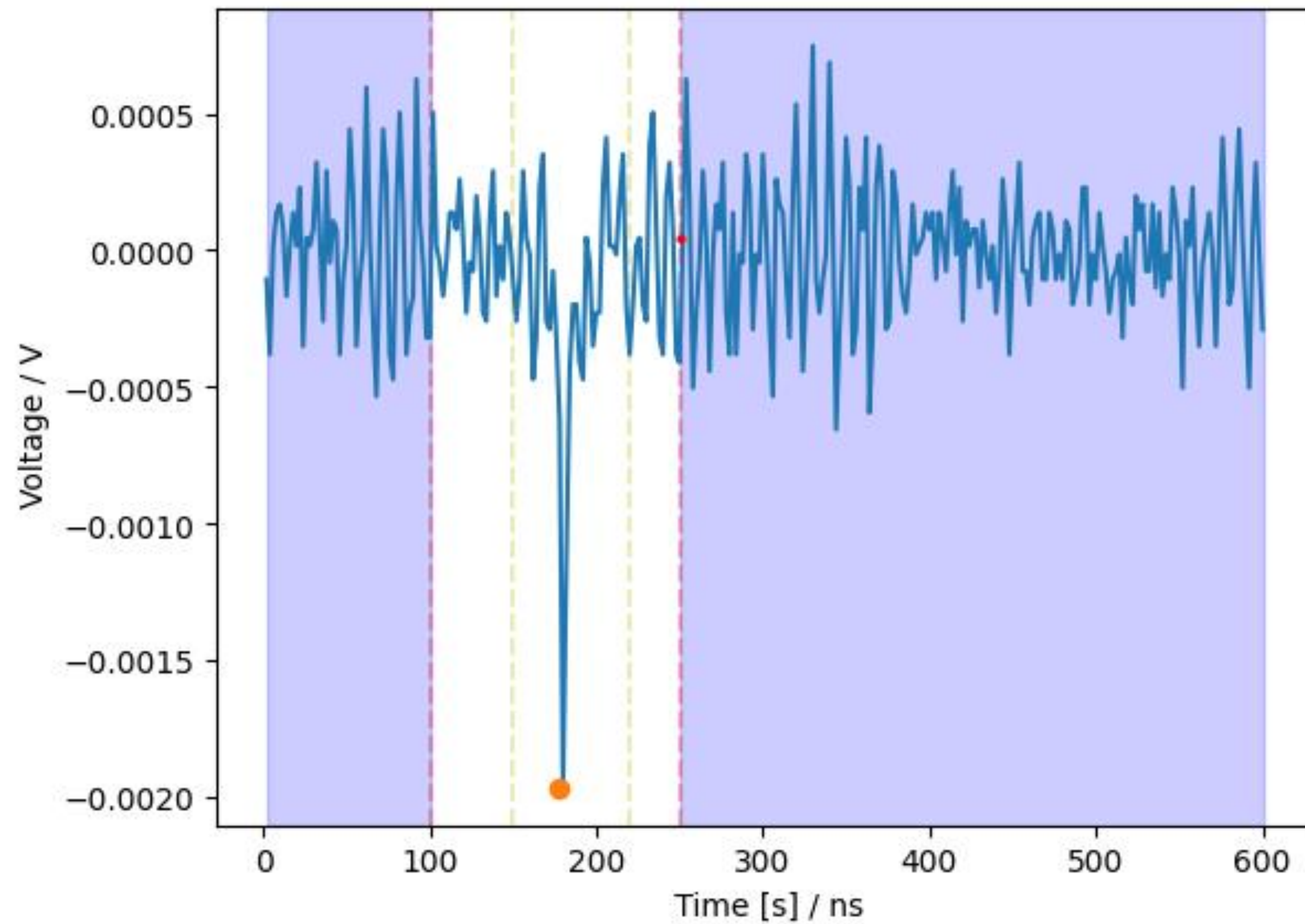
Signal generator: 1kHz, 50 ns steps



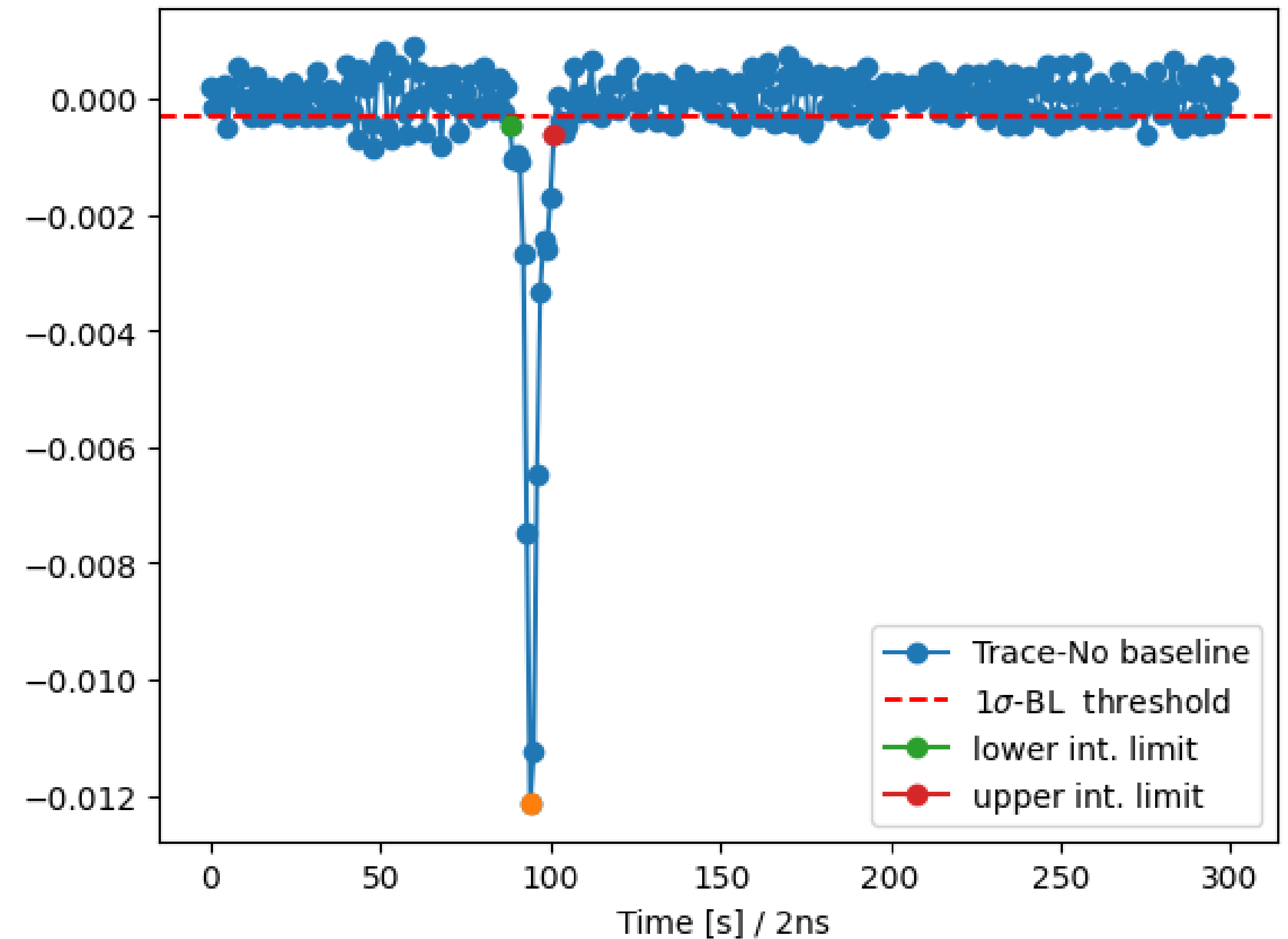
Power supply and signal digitizer (500 MHz)



Trace analysis



Selection cuts are applied to avoid high-noise traces



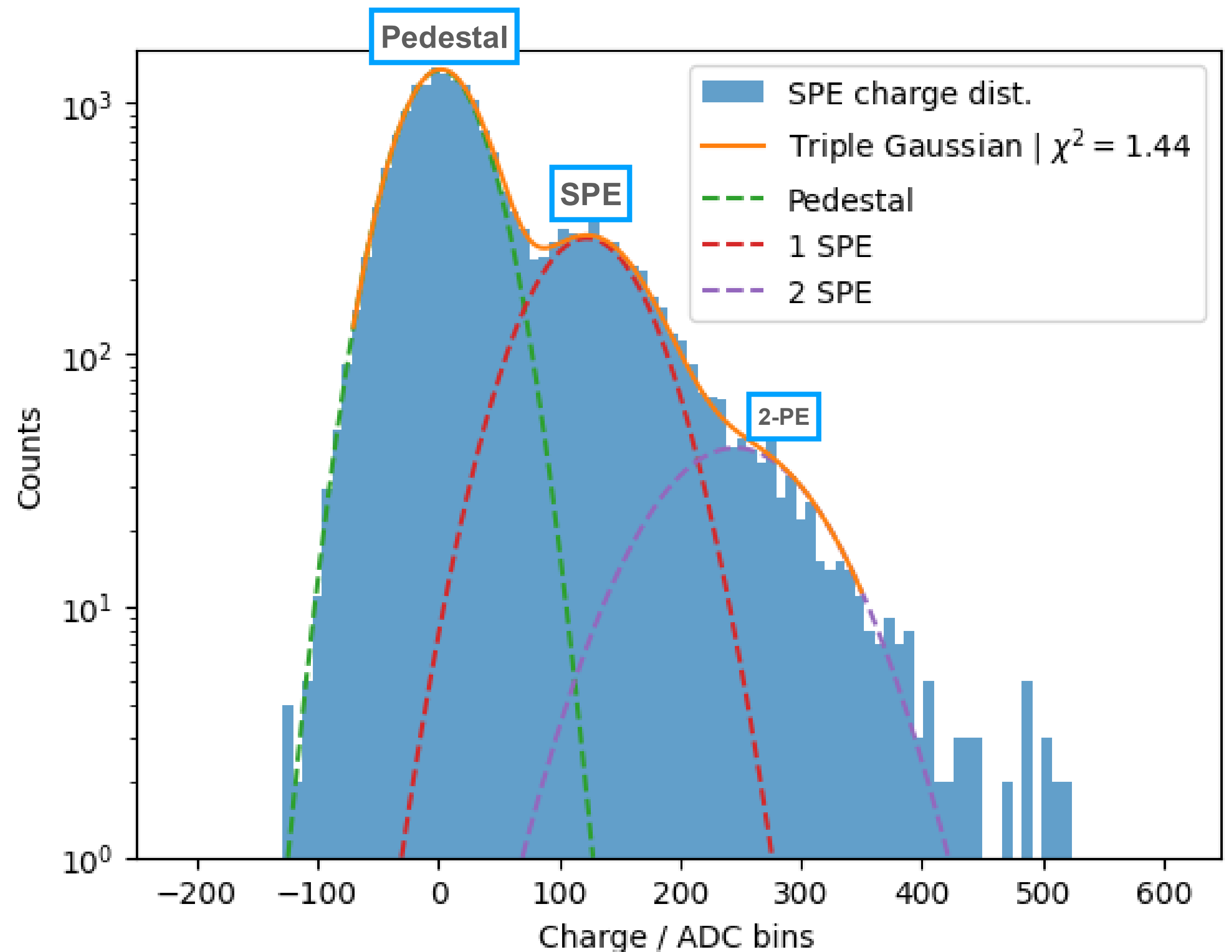
Integration window is calculated for each trace individually

Single photo-electron (SPE) spectrum

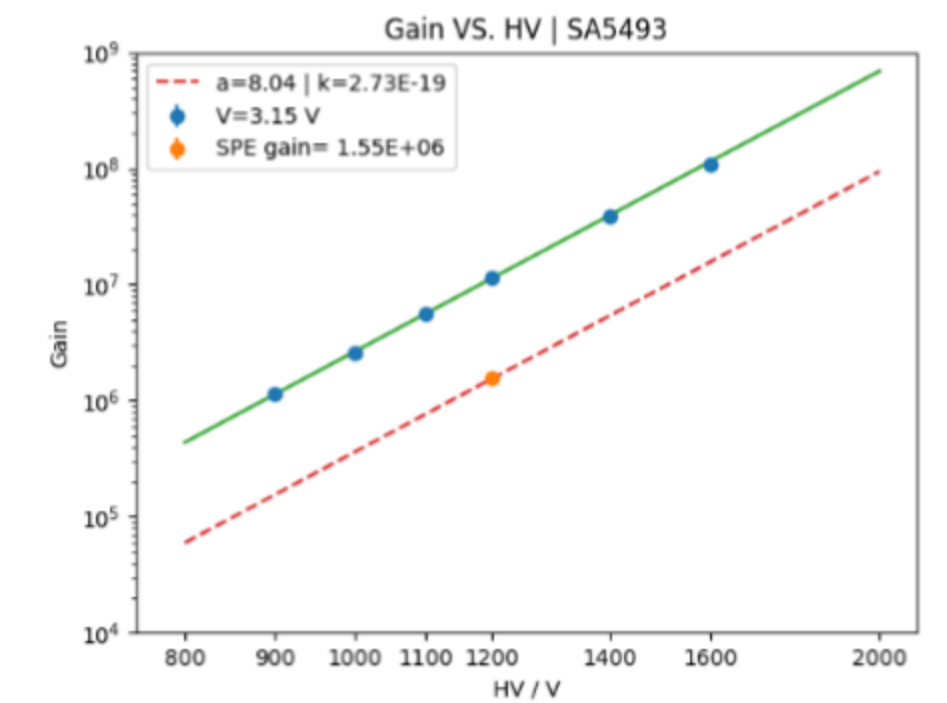
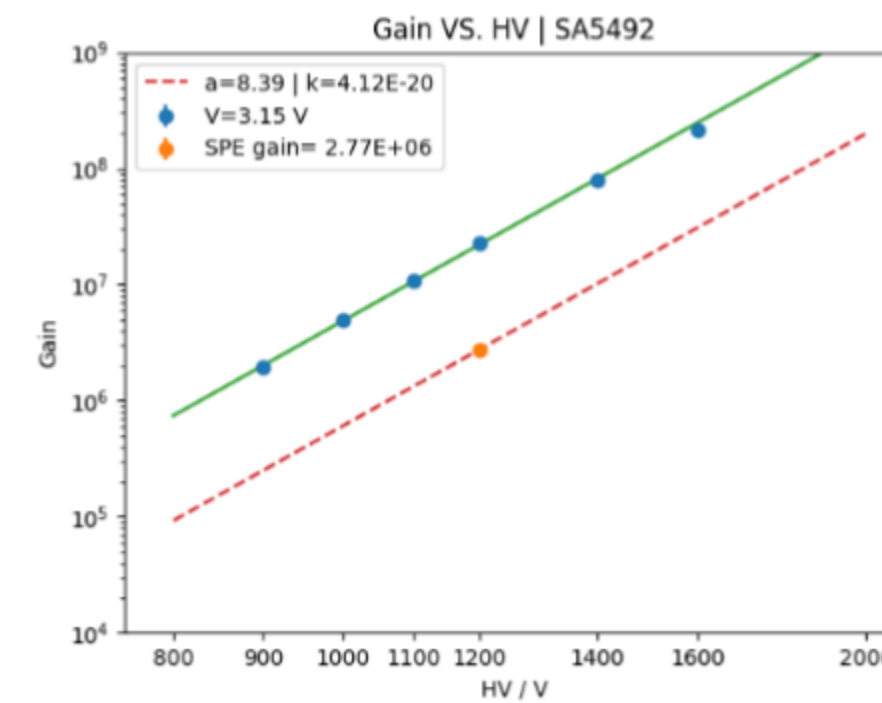
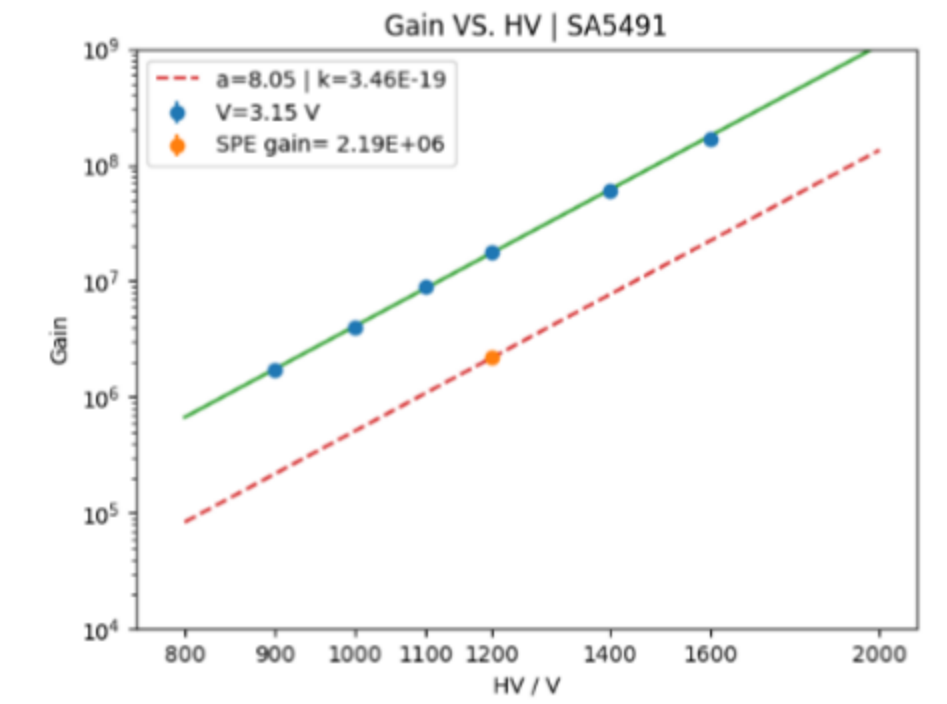
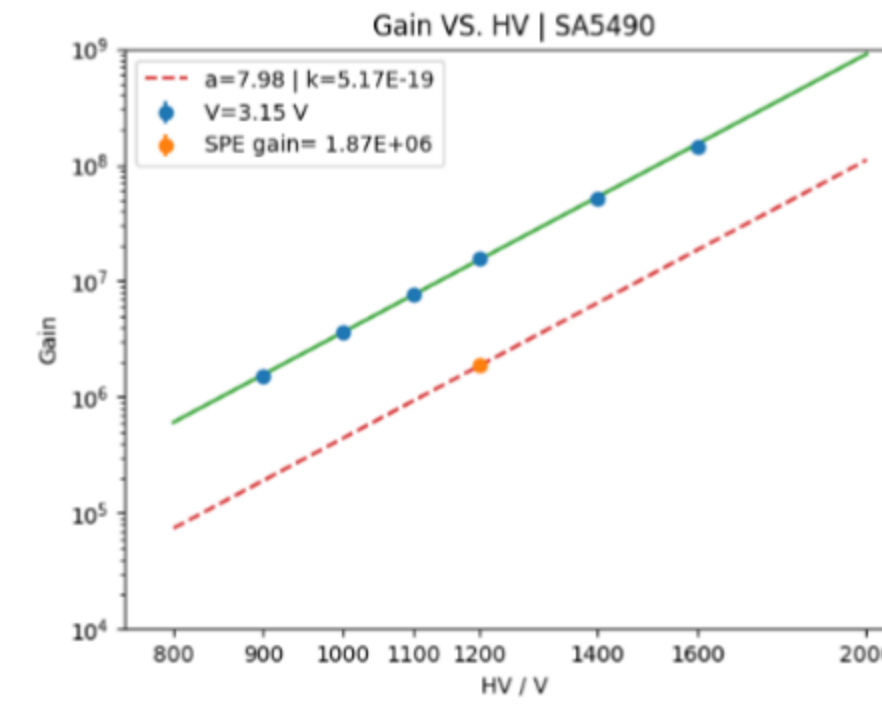
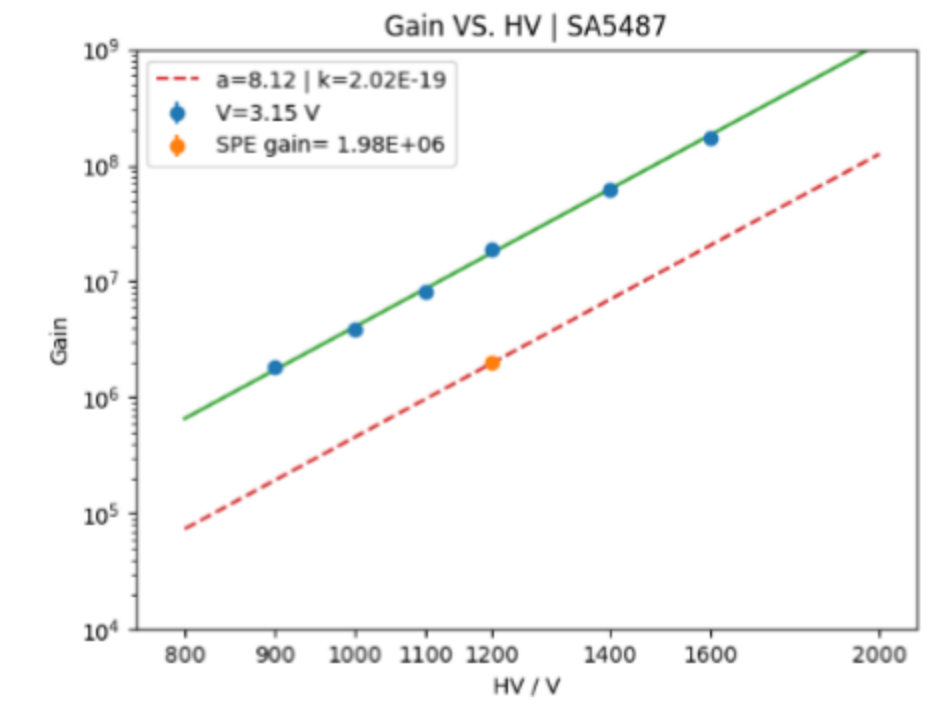
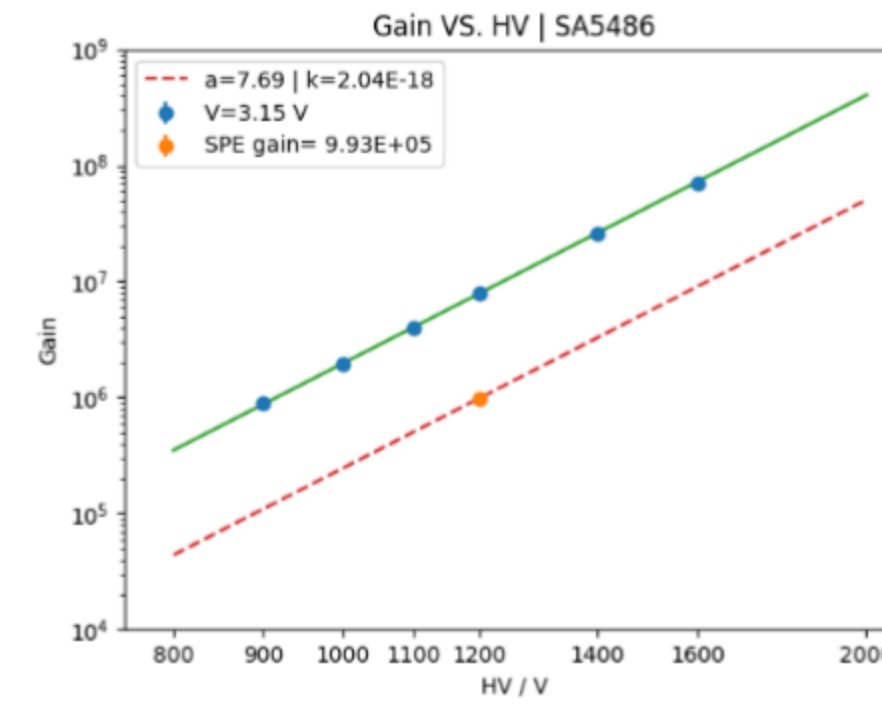
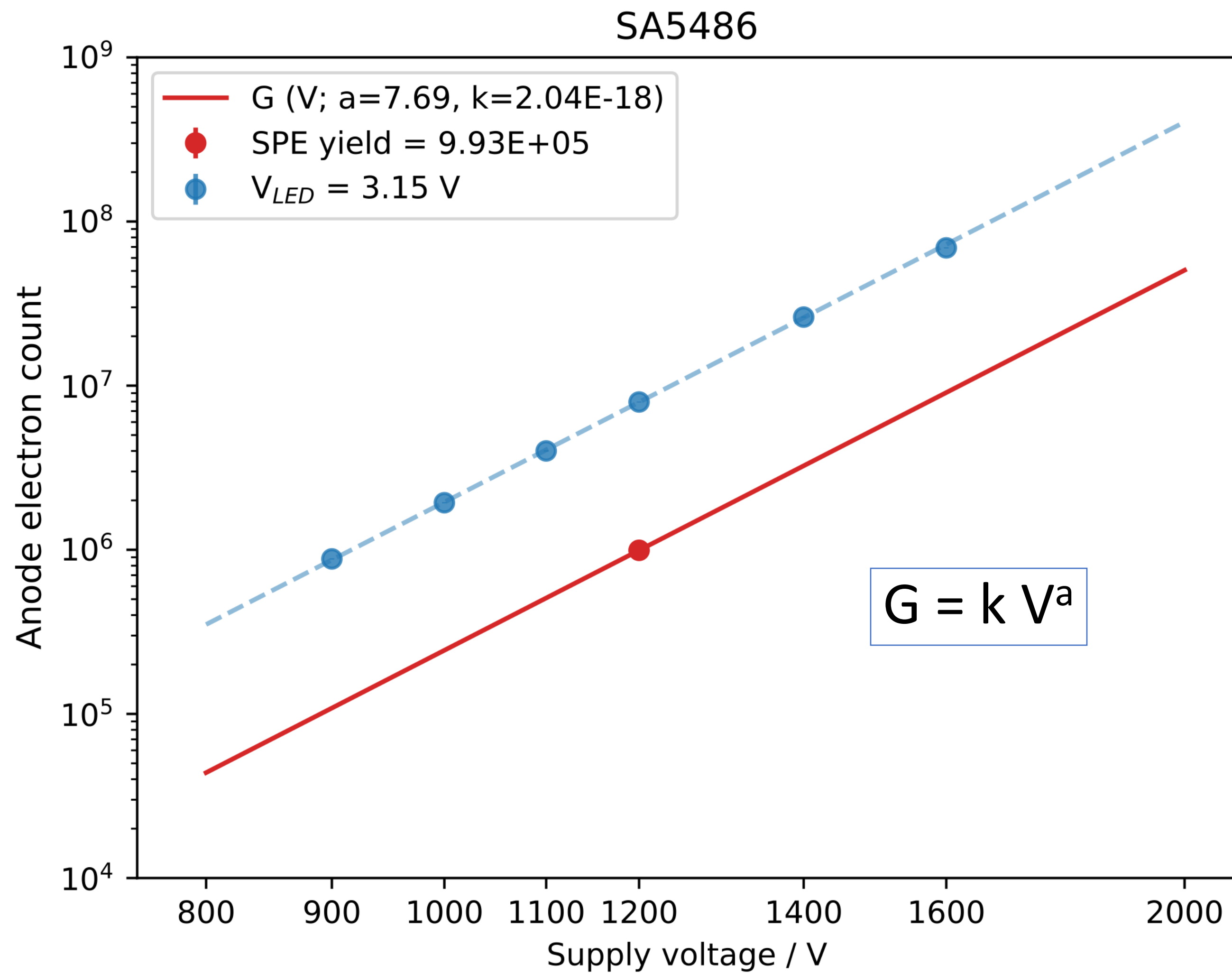
- Used a low light intensity for the LEDs
- The SPE, mean (μ_{SPE}) and variance (σ_{SPE}^2) are extracted from a fit of the full distribution
- The SPE gain and resolution are calculated for each PMT

- $$G = \frac{1}{e} \left[\frac{\Delta V}{D} \cdot \frac{\Delta t}{R} \right] \mu_{SPE}$$

$$G \sim 1.94 \times 10^6$$

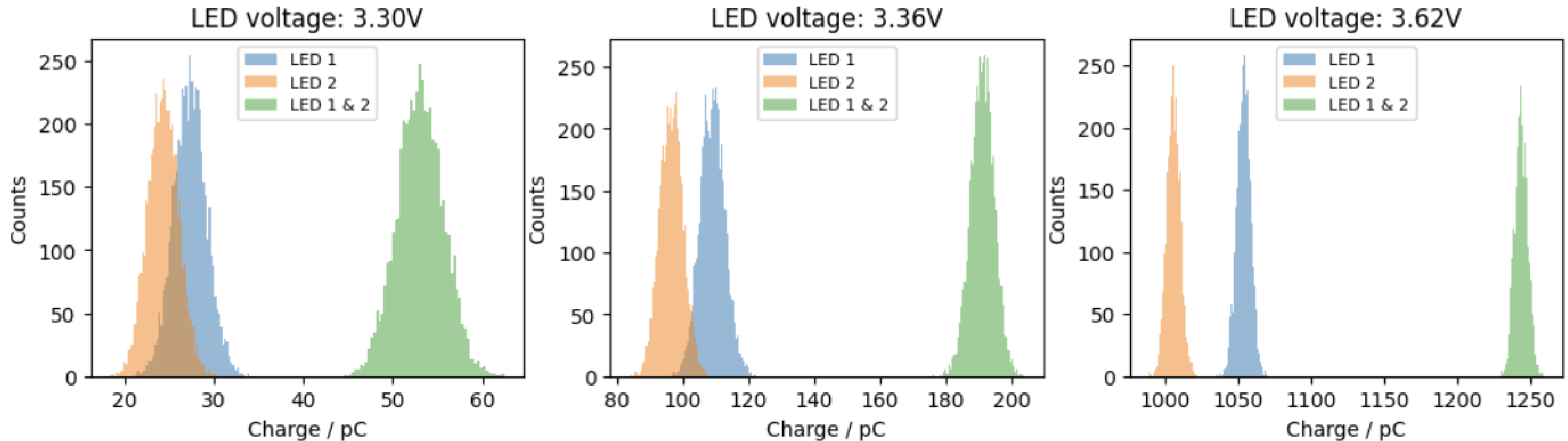
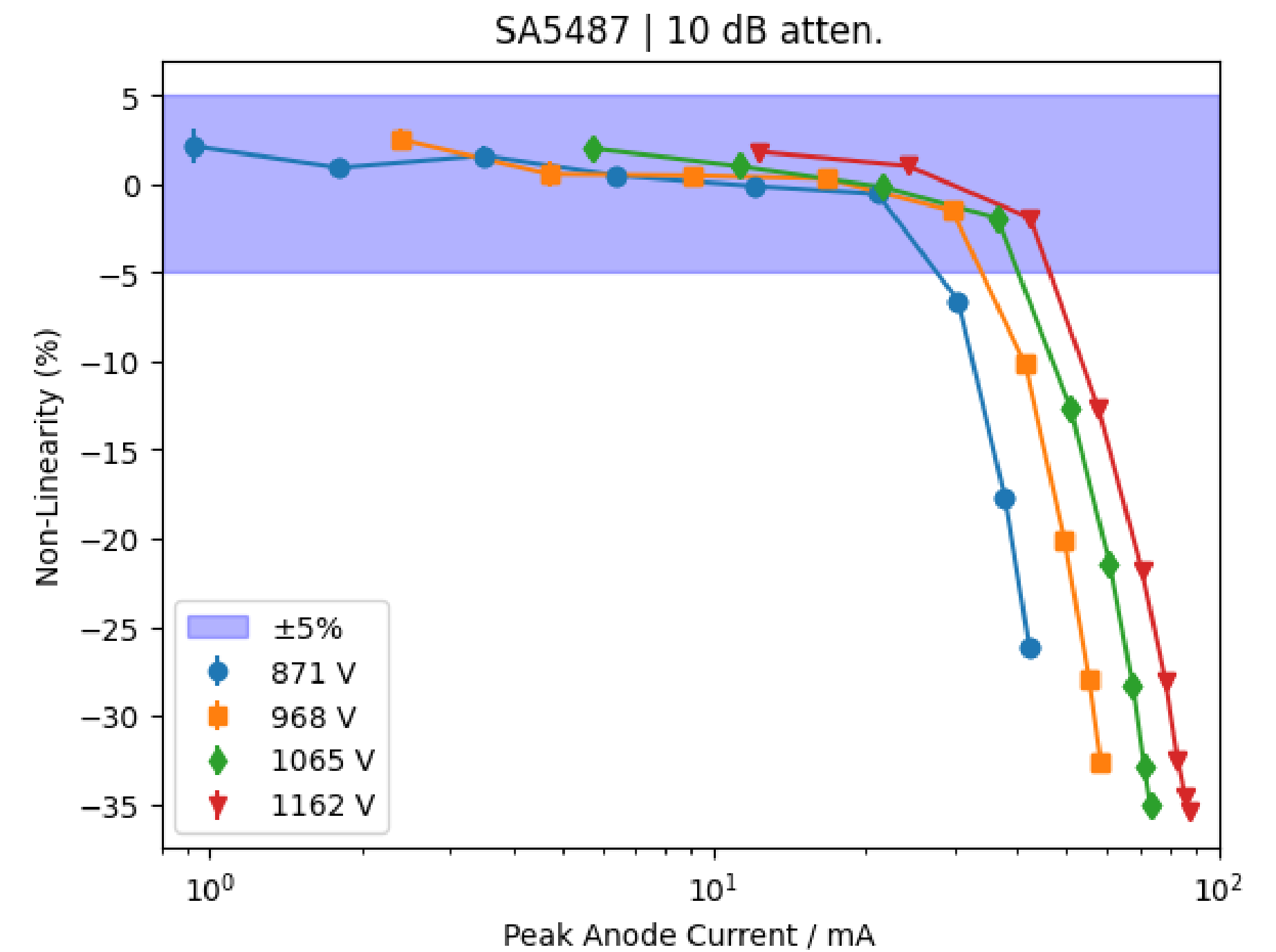


Gain VS. HV



Non-linearity

- Measurement procedure
 - LED A is fired.
 - LED B is fired.
 - LED A & B are fired.
- Charge is estimated in each case by fitting a normal distribution.
- Non-linearity **within 5% up to 50 mA (2.5 V)**

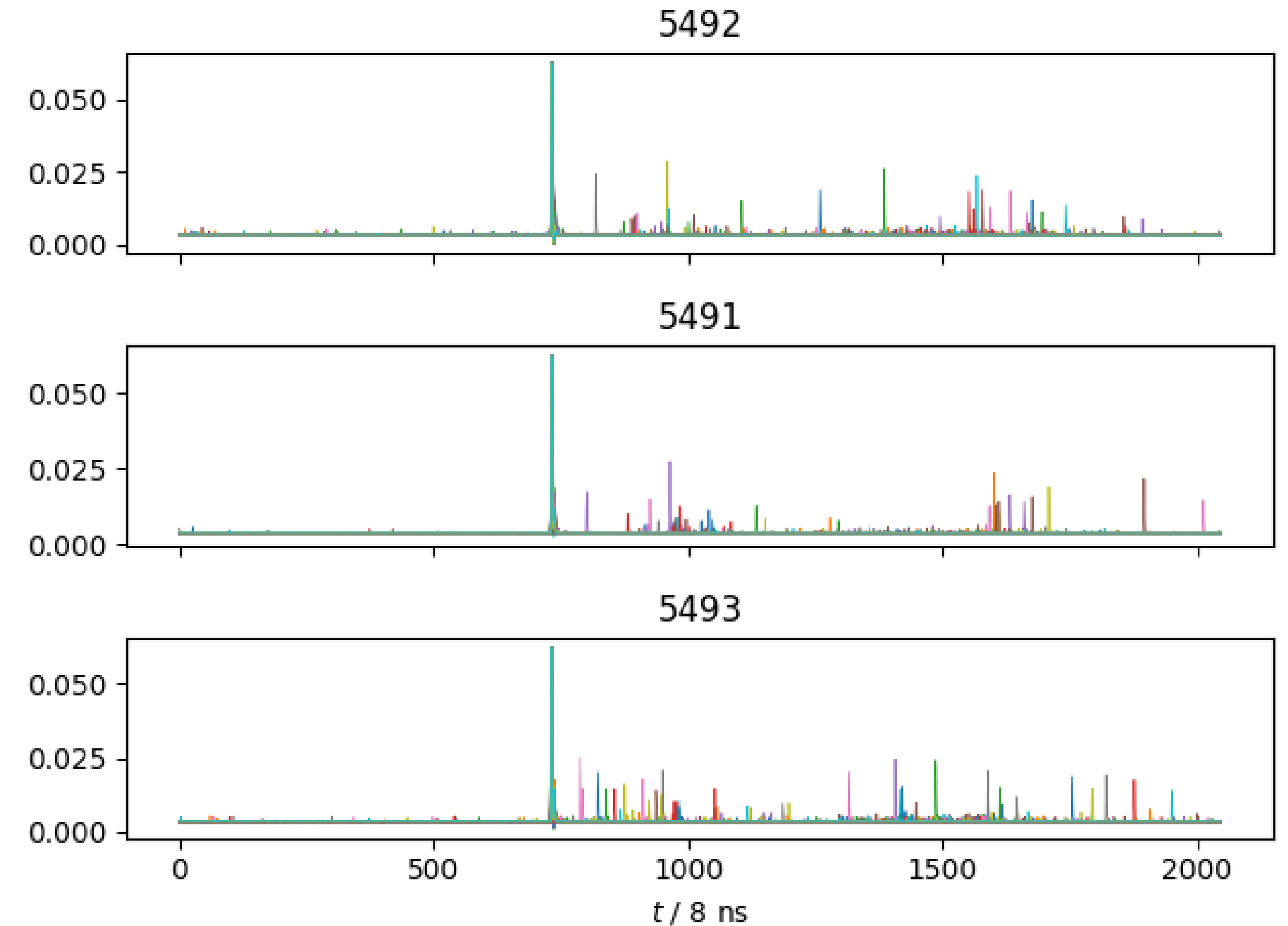
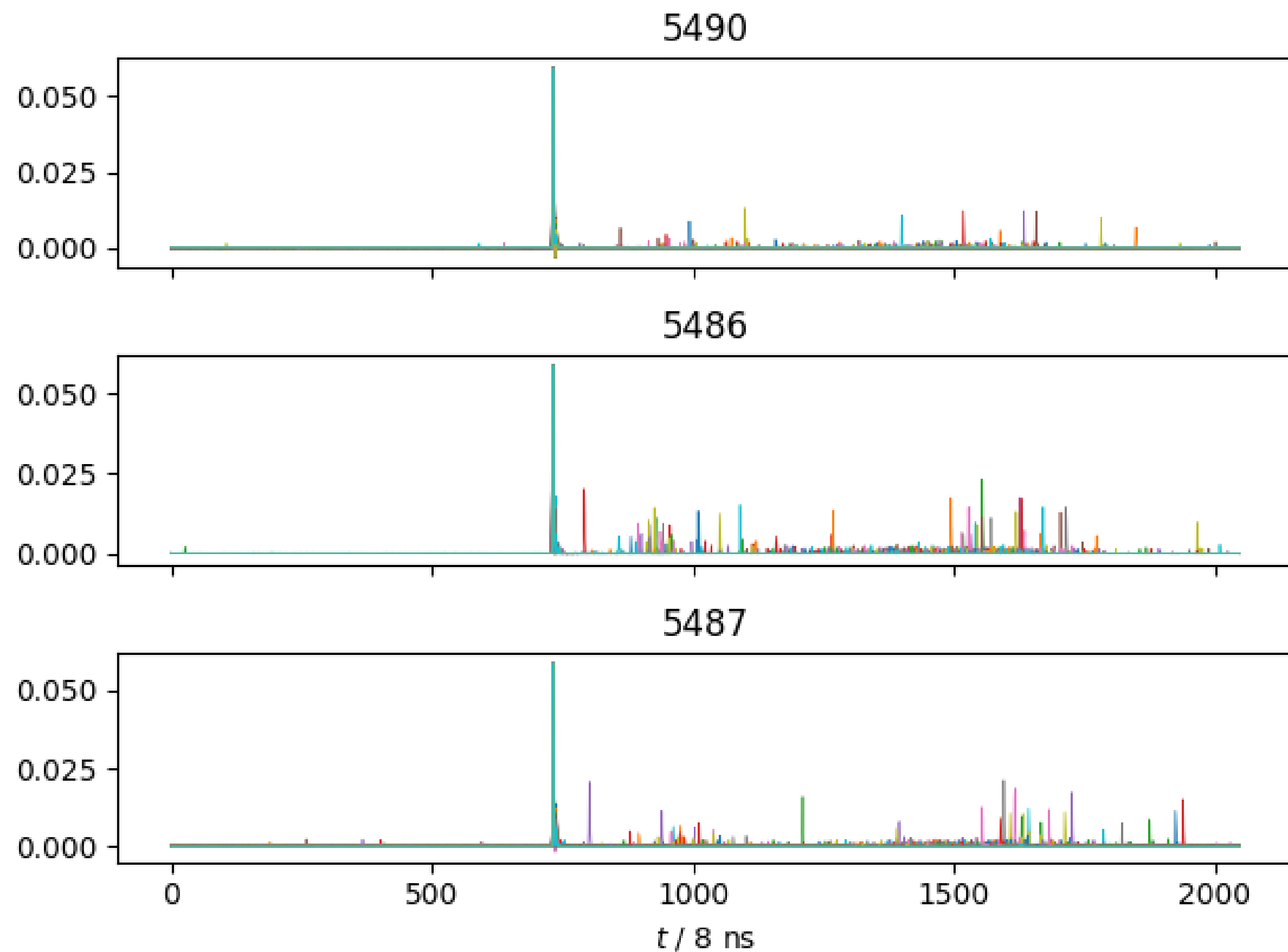


Afterpulses

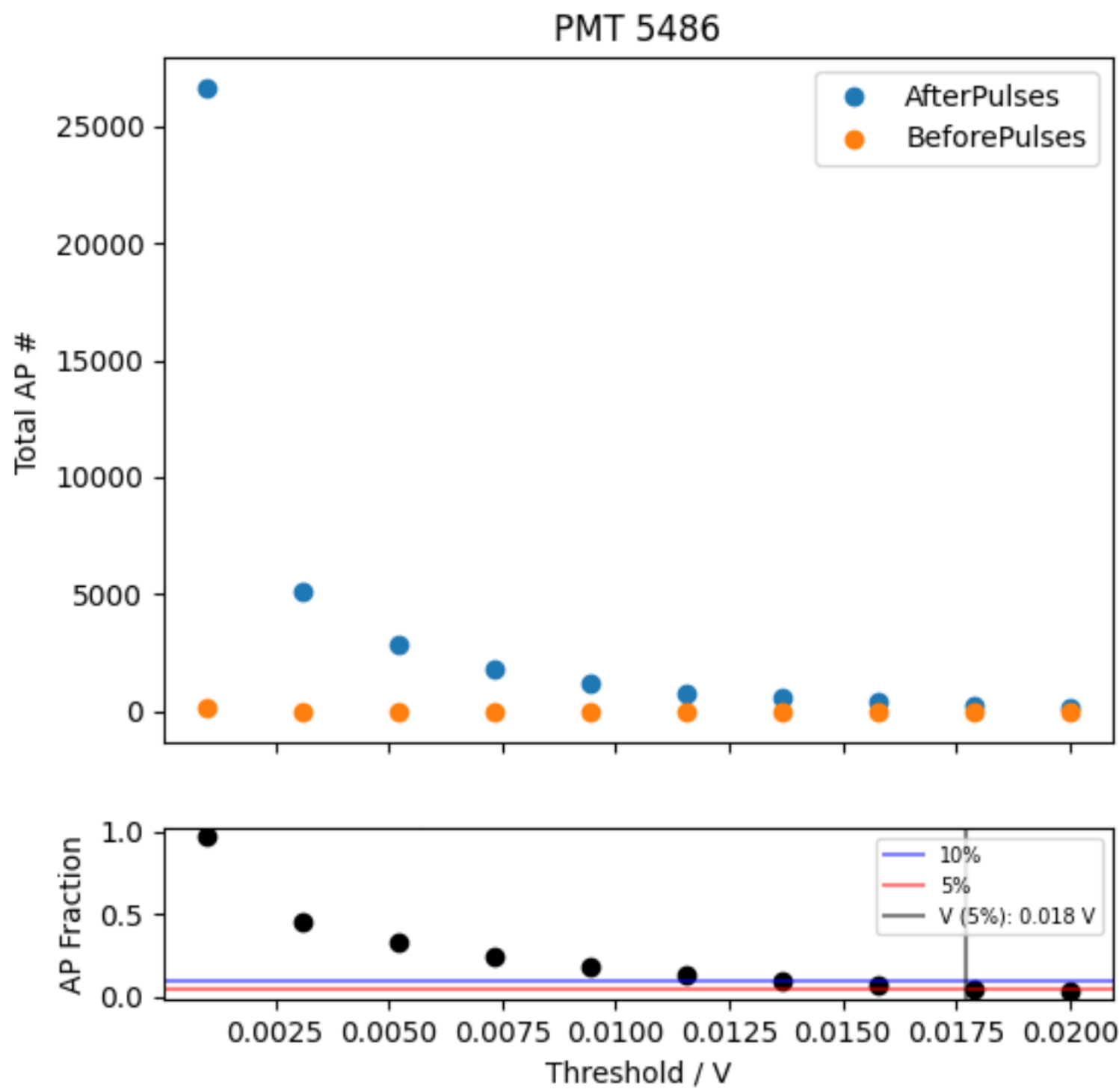
PMT interior is not 100% vacuum --> ionized molecules can drift and generate secondary electron cascades (in the photocatode/dynode)

UUB used for acquisition (125 Ms/s)

We use the "beforepulse" fraction to define the **base-threshold** --> **5 mV**

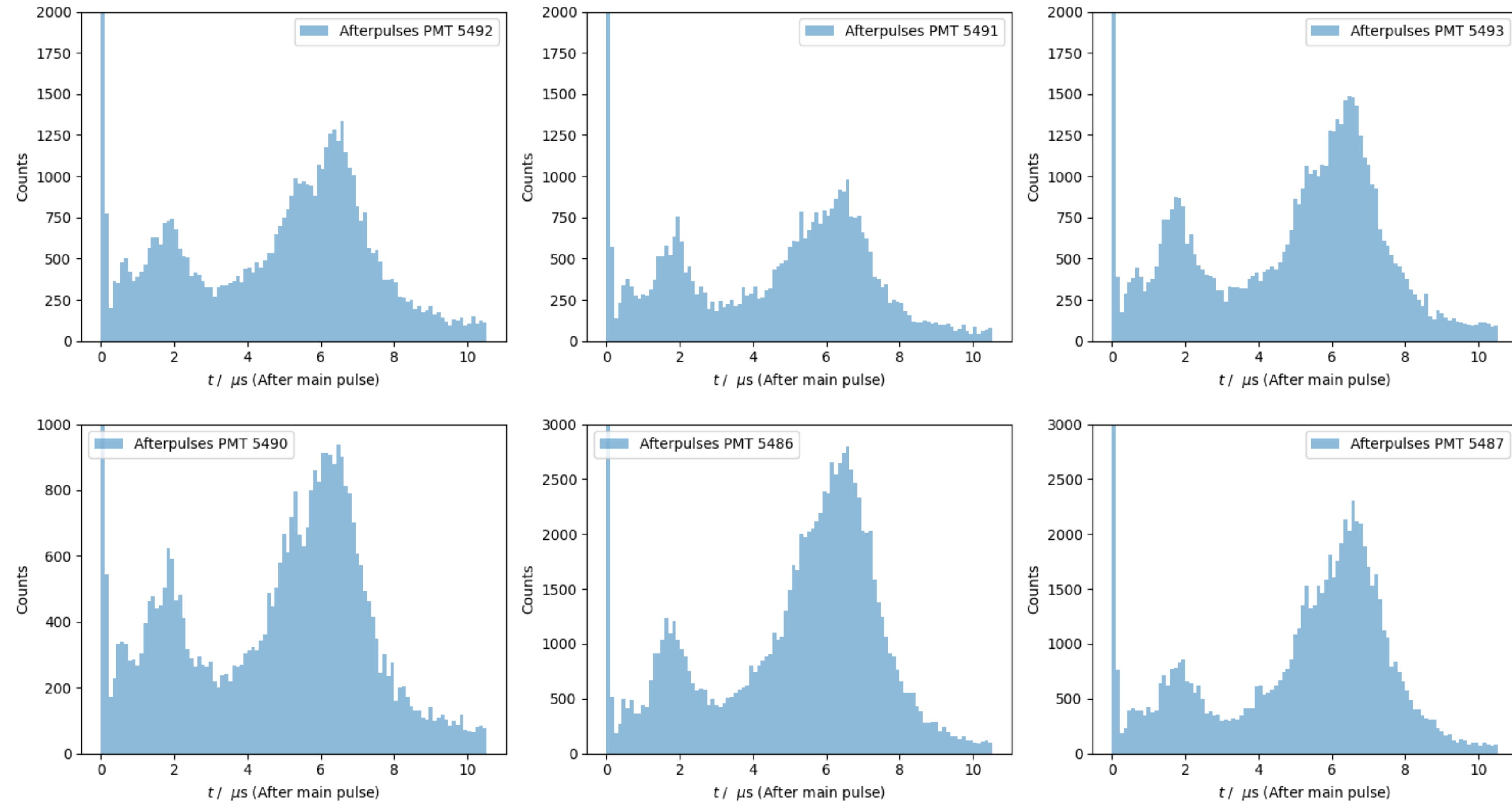


Afterpulses



AP fraction threshold dependence

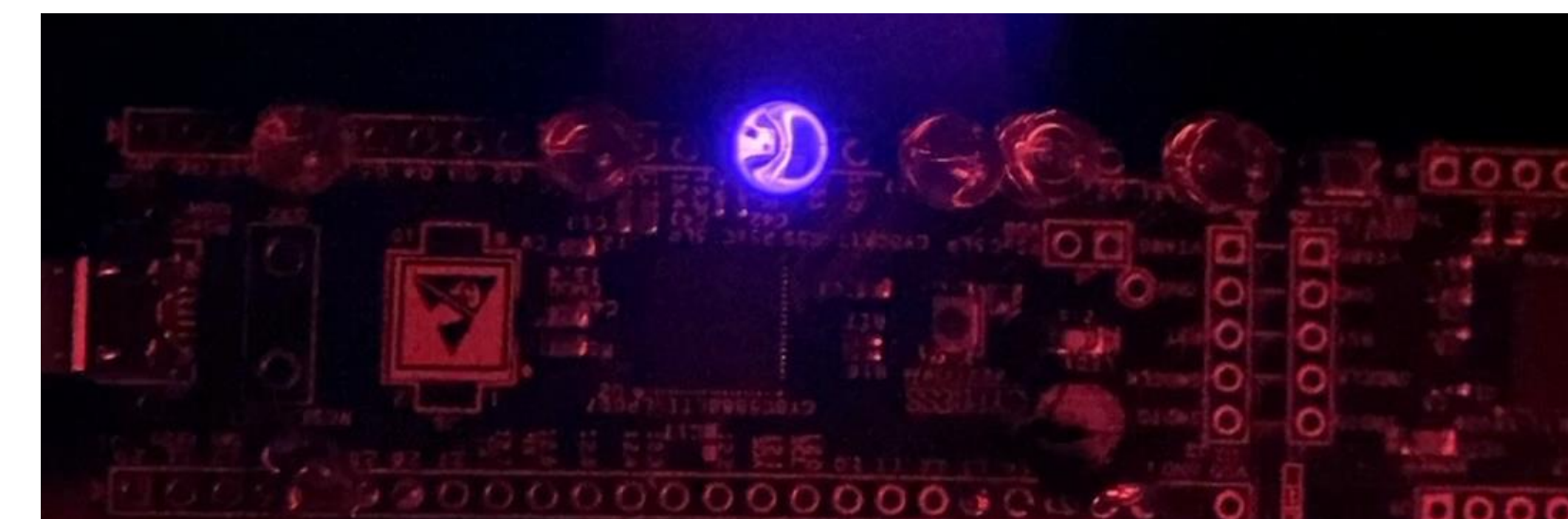
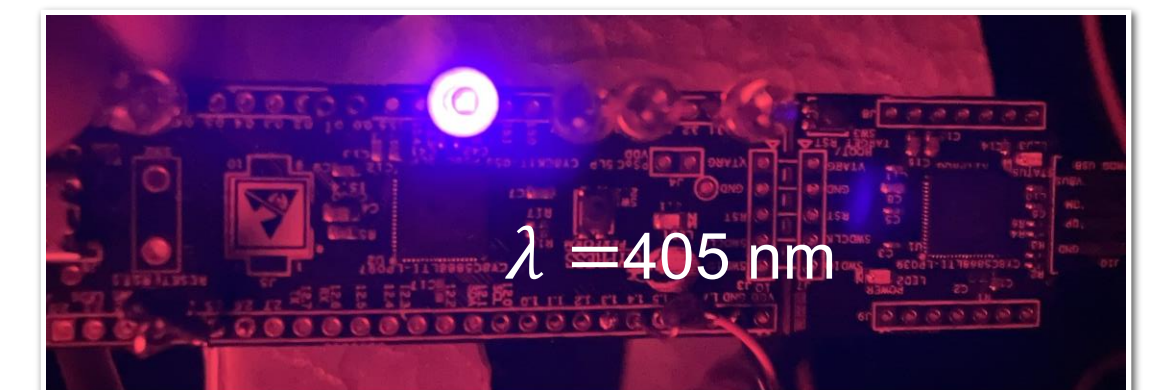
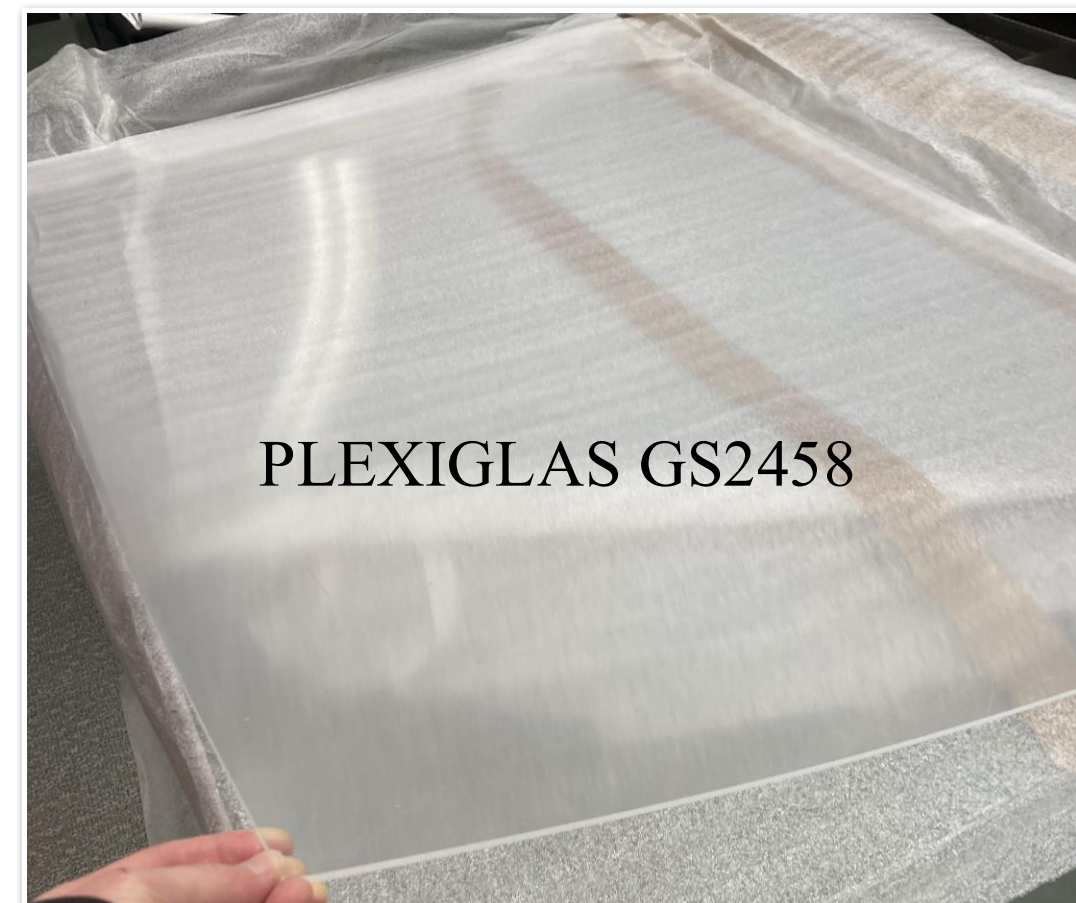
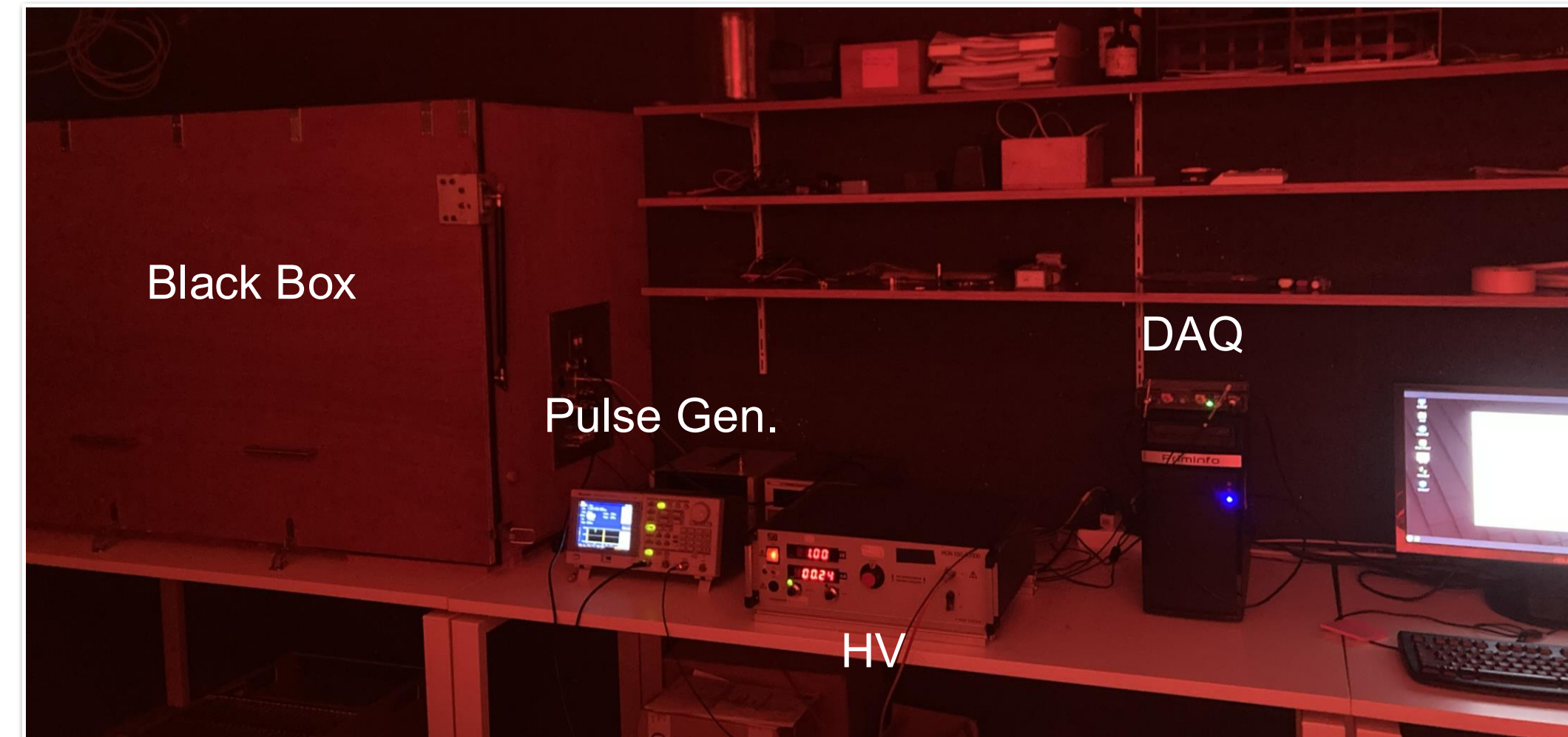
Drops below 5% above 15 mV



Time distributions with peaks @ 2 and 6 μs

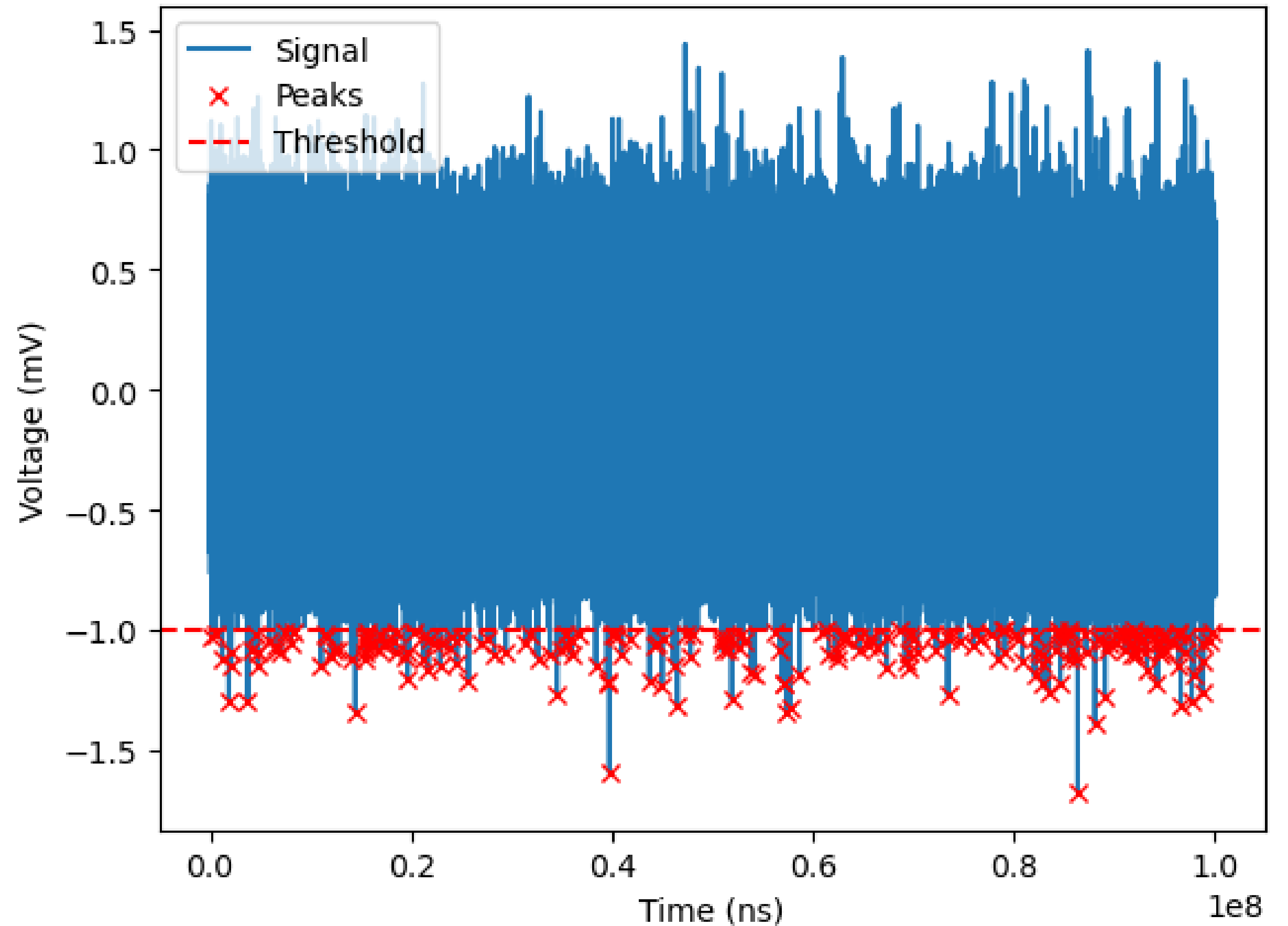
PMT testbench development in Brussels

- Performing independent cross-checks and other tests on future PMTs (quantum eff.)
- Optical window: plexiglass GS2458 custom-made (thermoforming+laser cutting) also to be tested



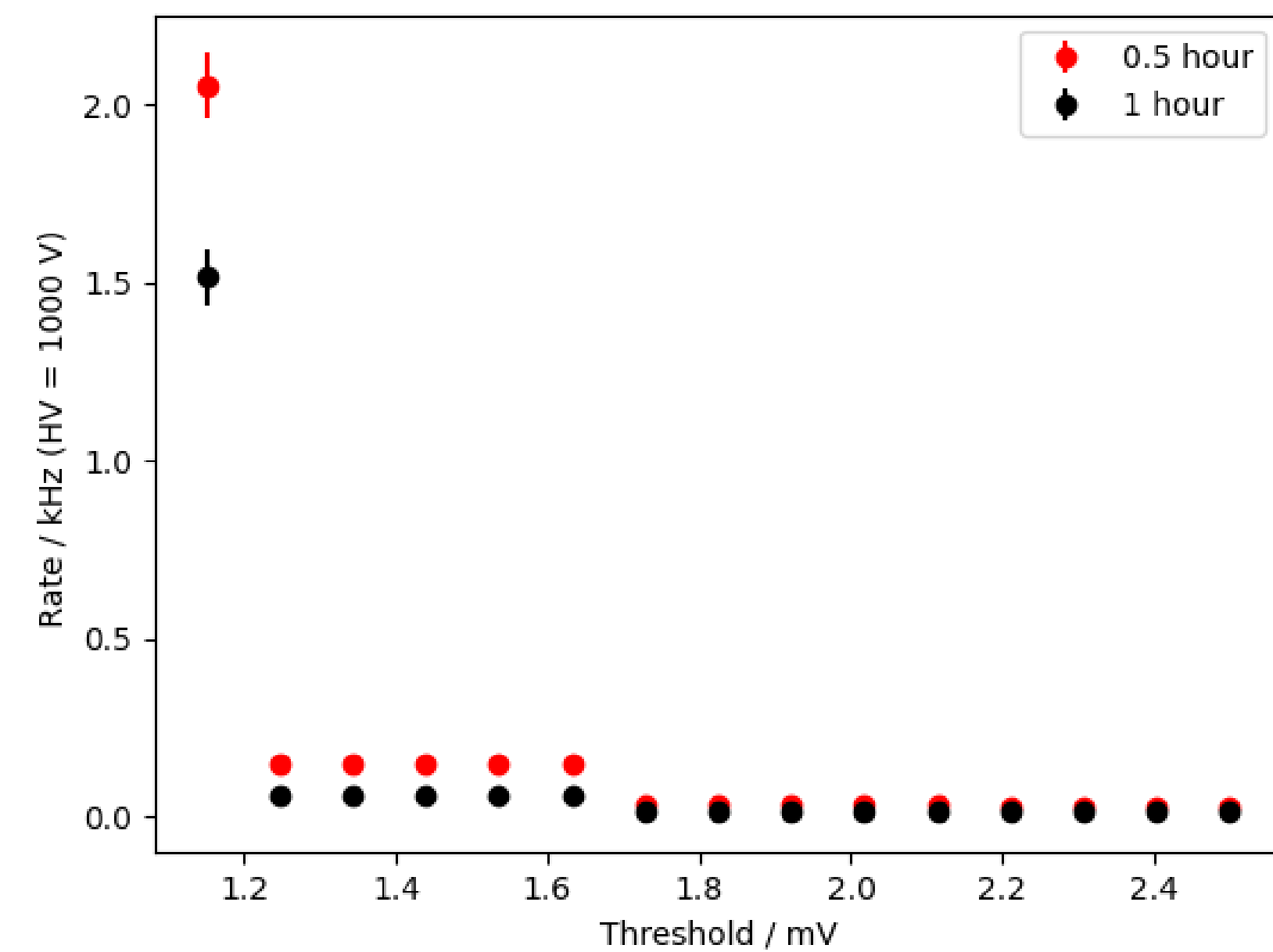
Dark rate measurements

- Dark rate: pulses above a certain threshold in the absence of light
- Mainly thermal noise and current leaks
- Sampling rate 250 MHz \rightarrow 4 ns
- 5000 traces
- Total time = 0.25 s (quite long)

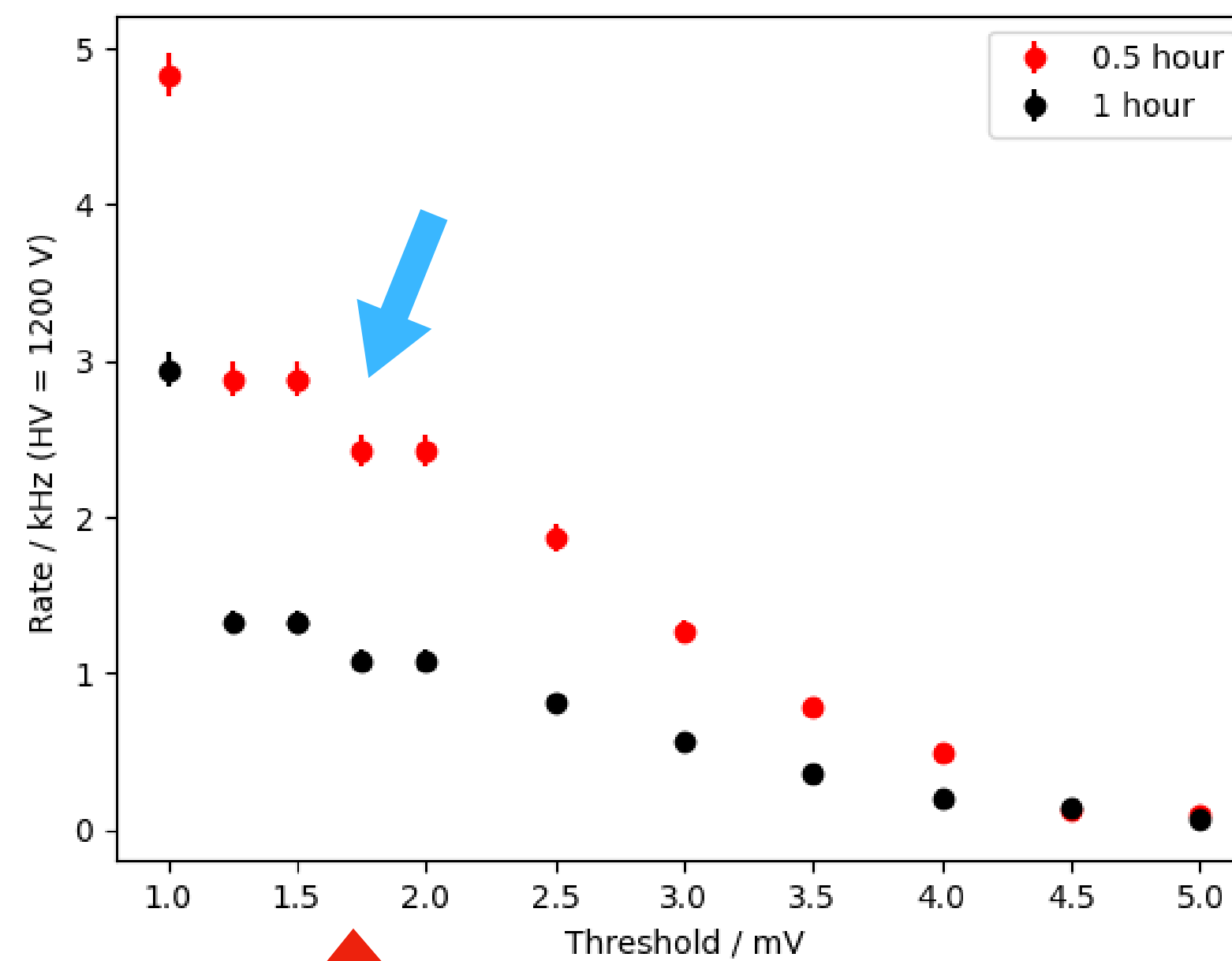


Dark rate vs. threshold

1000 V

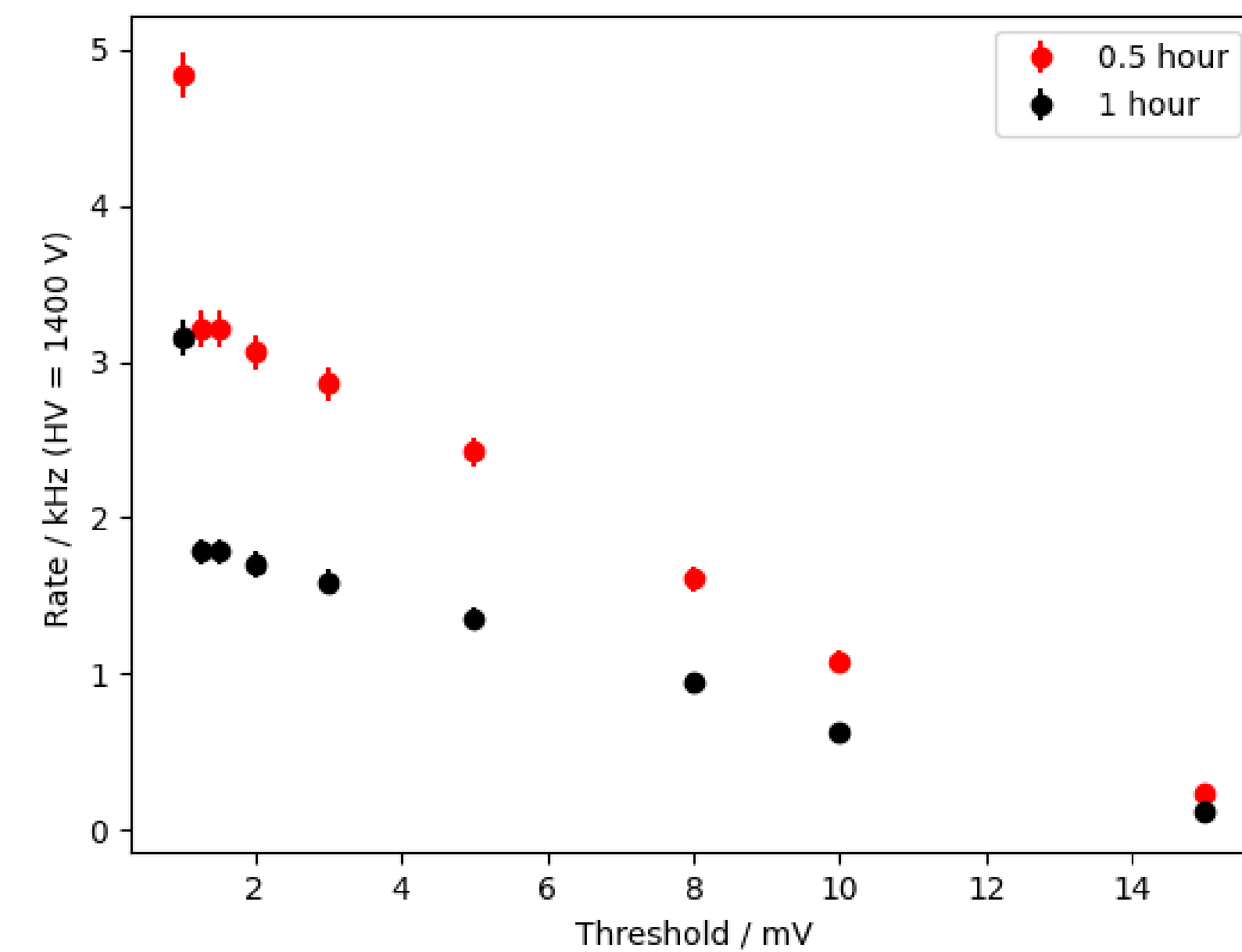


1200 V

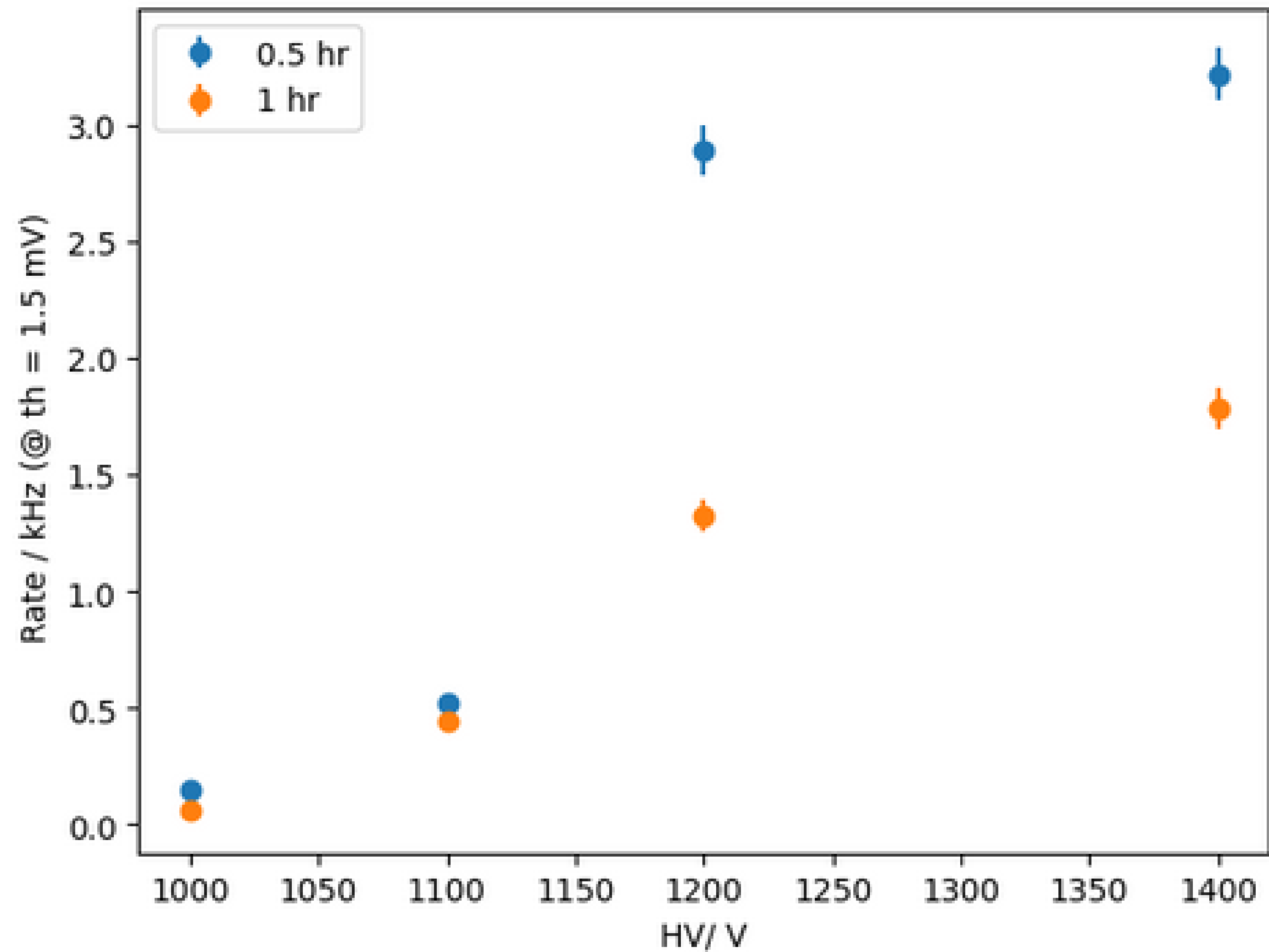


~ 1/4 p.e

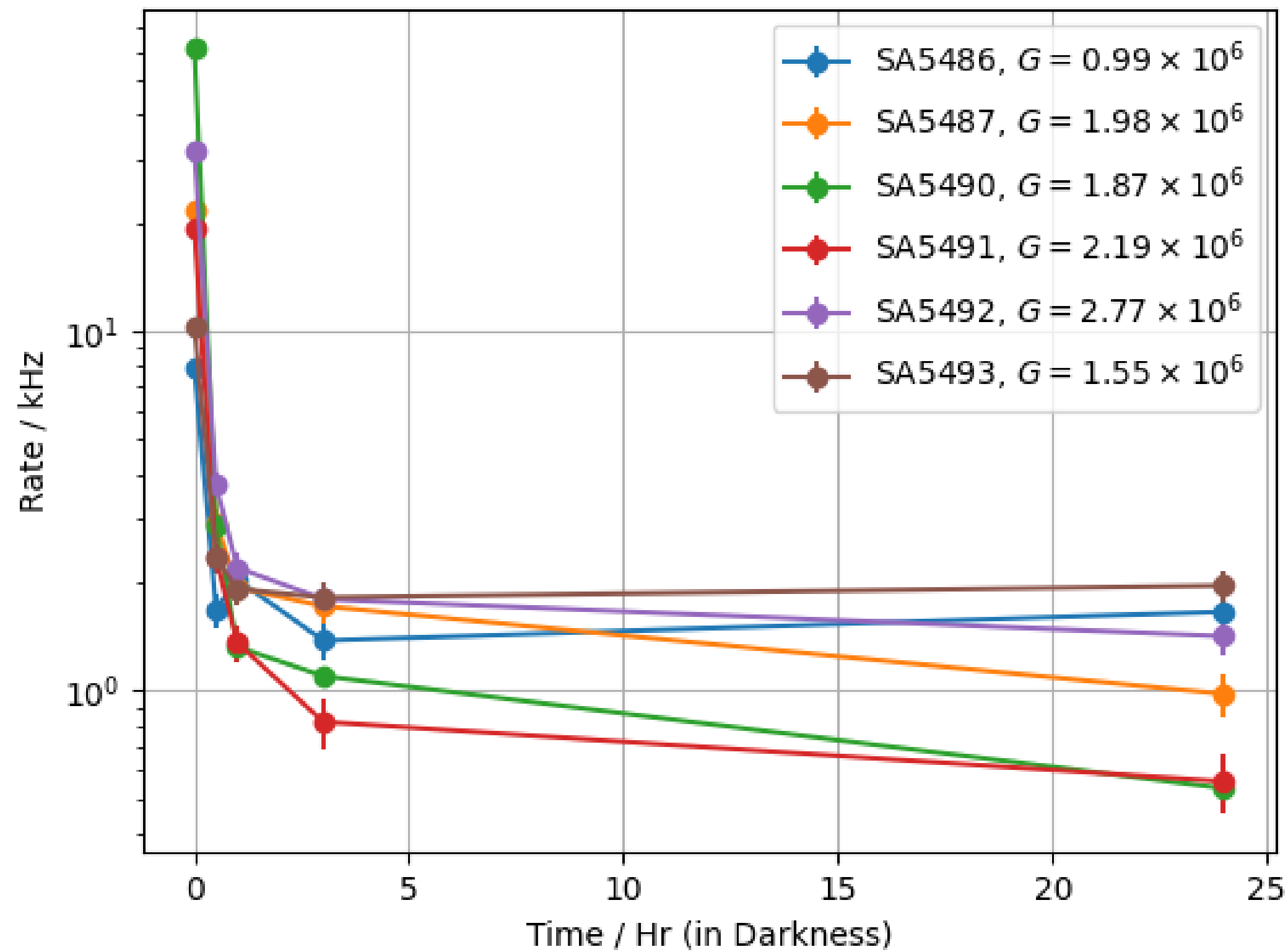
1400 V



Dark rate vs. HV (th = 1.5 mV)



Dark rate vs. time (in darkness)



		1500	2000	
Supply Voltage for Gain of 1×10^7		-	1500	2000
Anode Dark Current (after 30 min. storage in darkness)		-	100	1000
Dark Count (after 24 hrs. storage in darkness) *1		-	4000	8000
Time Response	Anode Pulse Rise Time	-	3.6	-
	Electron Transit Time	-	54	-
	Transit Time Spread (FWHM) *2	-	2	-
P/V (Peak to Valley) Ratio *2		2.0	3.0	-
Pulse Linearity at +/-2% deviation		-	40	-
Pulse Linearity at +/-5% deviation		-	60	-
After Pulse		-	6	10

NOTES

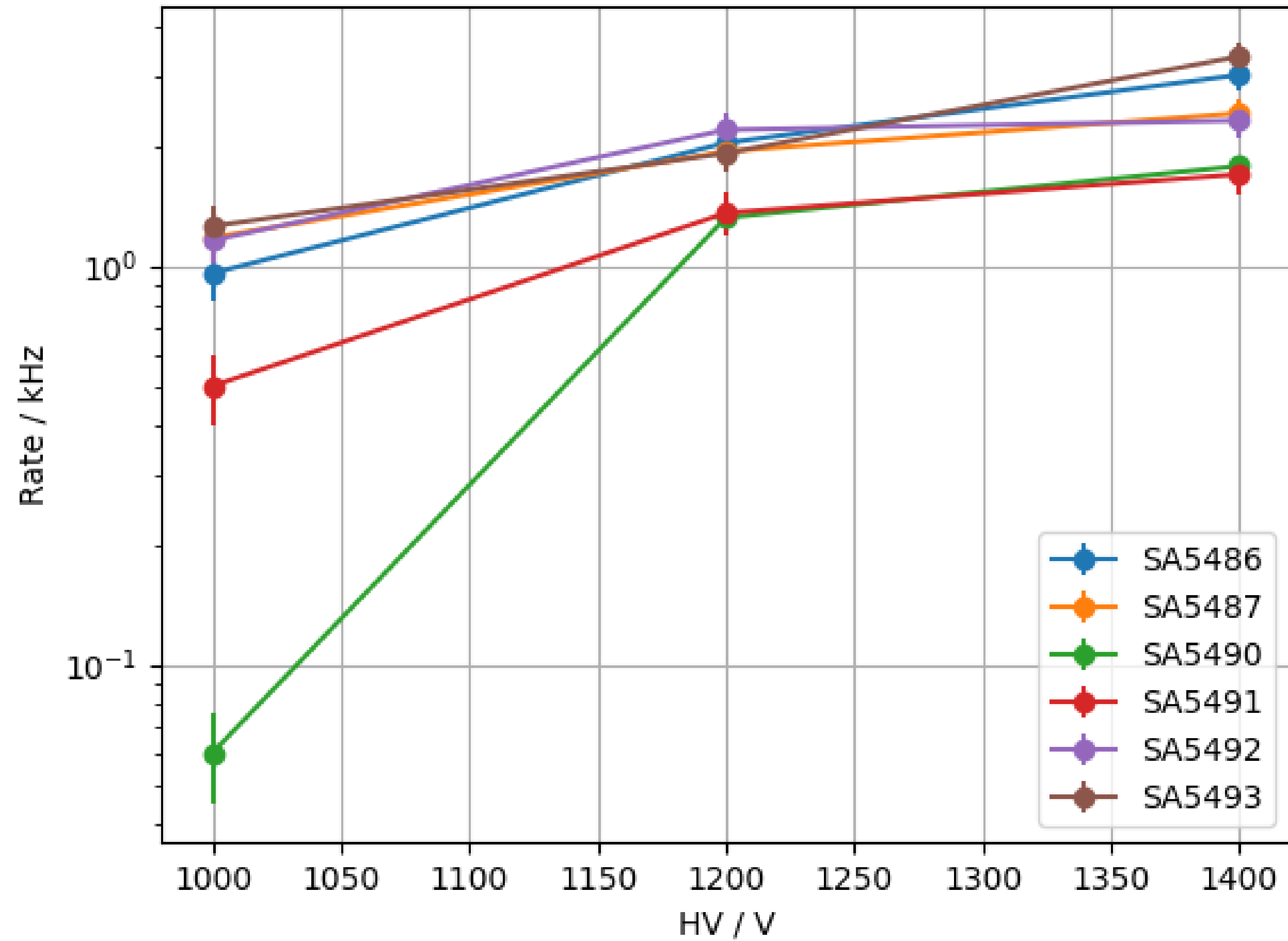
* Anode characteristics are measured with the standard voltage distribution ratio.

*1 LLD : 1/4 p.e.

*2 at single p.e.

VOLTAGE DISTRIBUTION RATIO AND SUPPLY VOLTAGE

Dark rate vs. HV (60 min in darkness)



Summary

- 6 Hamamatsu R5912 PMTs were characterized in Prague and Brussels testbenches
- Average gain of $\sim 2 \times 10^6$ with a 1-sigma spread of 30%
- Non-linearity: within 5% up to 50 mA – 2.5 V
- Afterpulse fraction below 5% for thresholds above 15 mV
- Dark rate around 1 kHz after 3 hours

